

Notice of References Cited	Application/Control No. 10/697,122	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Jennifer T. Nguyen	Art Unit 2629	Page 1 of 1

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*	B	US-6,597,488	07-2003	Johnson et al.	359/245
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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